

# Normally – OFF Silicon Carbide Junction Transistor

#### Features

- 175 °C Maximum Operating Temperature
- Gate Oxide Free SiC Switch
- Exceptional Safe Operating Area
- Excellent Gain Linearity
- Temperature Independent Switching Performance

• Compatible with Si MOSFET/IGBT Gate Drive ICs

• > 20 µs Short-Circuit Withstand Capability

• Lowest-in-class Conduction Losses

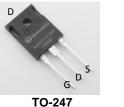
• Low Output Capacitance

**Advantages** 

High Circuit EfficiencyMinimal Input Signal Distortion

• High Amplifier Bandwidth

- Positive Temperature Coefficient of  $\mathsf{R}_{\mathsf{DS},\mathsf{ON}}$
- Suitable for Connecting an Anti-parallel Diode





Package

RoHS Compliant

#### Applications

- Down Hole Oil Drilling, Geothermal Instrumentation
- Hybrid Electric Vehicles (HEV)
- Solar Inverters
- Switched-Mode Power Supply (SMPS)
- Power Factor Correction (PFC)
- Induction Heating
- Uninterruptible Power Supply (UPS)
- Motor Drives

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#### Section I: Absolute Maximum Ratings

Parameter	Symbol	Conditions	Value	Unit	Notes
Drain – Source Voltage	V <sub>DS</sub>	$V_{GS} = 0 V$	1200	V	
Continuous Drain Current	ID	$T_{\rm C} = 25^{\circ}{\rm C}$	45	А	Fig. 17
Continuous Drain Current	ID	T <sub>C</sub> = 145°C	20	А	Fig. 17
Continuous Gate Current	l <sub>G</sub>		1.3	А	
Turn-Off Safe Operating Area	RBSOA	T <sub>VJ</sub> = 175 °C, Clamped Inductive Load	I <sub>D,max</sub> = 20 @ V <sub>DS</sub> ≤ V <sub>DSmax</sub>	А	Fig. 19
Short Circuit Safe Operating Area	SCSOA	$T_{VJ} = 175 \ ^{\circ}C$ , $I_G = 1 \ A$ , $V_{DS} = 800 \ V$ , Non Repetitive	>20	μs	
Reverse Gate – Source Voltage	V <sub>SG</sub>		30	V	
Reverse Drain – Source Voltage	V <sub>SD</sub>		25	V	
Power Dissipation	P <sub>tot</sub>	$T_{C} = 25 \text{ °C} / 145 \text{ °C}, t_{p} > 100 \text{ ms}$	282 / 56	W	Fig. 16
Storage Temperature	T <sub>stg</sub>		-55 to 175	°C	

# $\begin{array}{rcrcrc} V_{DS} & = & 1200 \ V \\ R_{DS(ON)} & = & 50 \ m\Omega \\ I_{D \ (Tc \ = \ 25^{\circ}C)} & = & 45 \ A \\ I_{D \ (Tc \ > \ 125^{\circ}C)} & = & 20 \ A \end{array}$

 $h_{FE(Tc = 25^{\circ}C)} = 96$ 

## GA20JT12-247

## **Section II: Static Electrical Characteristics**

Deveneter	Cumula al	Conditions	Value			1114	Nataa
Parameter	Symbol	Conditions	Min.	Typical	Max.	Unit	Notes
A: On State							
Drain – Source On Resistance	R <sub>DS(ON)</sub>	$ \begin{array}{l} I_{D} = 20 \mbox{ A}, \mbox{ T}_{j} = 25 \mbox{ °C} \\ I_{D} = 20 \mbox{ A}, \mbox{ T}_{j} = 150 \mbox{ °C} \\ I_{D} = 20 \mbox{ A}, \mbox{ T}_{j} = 175 \mbox{ °C} \end{array} $		50 93 109		mΩ	Fig. 4
Gate – Source Saturation Voltage	$V_{\text{GS},\text{SAT}}$	$V_{GS,SAT}$ $I_D = 20 \text{ A}, I_D/I_G = 40, T_j = 25 \text{ °C}$ $I_D = 20 \text{ A}, I_D/I_G = 30, T_j = 175 \text{ °C}$		3.44 3.24		V	Fig. 7
DC Current Gain	$ \begin{array}{l} V_{DS} = 8 \; V, \; I_D = 20 \; A, \; T_J = 25 \; ^\circ C \\ h_FE & V_DS = 8 \; V, \; I_D = 20 \; A, \; T_J = 125 \; ^\circ C \\ V_DS = 8 \; V, \; I_D = 20 \; A, \; T_J = 175 \; ^\circ C \end{array} $			96 62 56		_	Fig. 5
B: Off State							
Drain Leakage Current	I <sub>DSS</sub>			0.1 0.1 0.2		μA	Fig. 8
Gate Leakage Current	I <sub>SG</sub>	$V_{SG} = 20 \text{ V}, \text{ T}_{j} = 25 \text{ °C}$		20		nA	
C: Thermal							
Thermal resistance, junction - case	R <sub>thJC</sub>			0.53		°C/W	Fig. 20

## Section III: Dynamic Electrical Characteristics

Deremeter	Sumhel Conditions			Value		L In ??	Nete
Parameter	Symbol	Conditions	Min.	Typical	Max.	Unit	Notes
A: Capacitance and Gate Charge	e						
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 800 V, <i>f</i> = 1 MHz		3091		pF	Fig. 9
Reverse Transfer/Output Capacitance	$C_{rss}/C_{oss}$	V <sub>DS</sub> = 800 V, <i>f</i> = 1 MHz		53		pF	Fig. 9
Output Capacitance Stored Energy	Eoss	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 800 V, <i>f</i> = 1 MHz		22		μJ	Fig. 10
Effective Output Capacitance, time related	$C_{\text{oss,tr}}$	$I_{\text{D}}$ = constant, $V_{\text{GS}}$ = 0 V, $V_{\text{DS}}$ = 0…800 V		96		pF	
Effective Output Capacitance, energy related	$C_{\text{oss,er}}$	$V_{GS}$ = 0 V, $V_{DS}$ = 0800 V		70		pF	
Gate-Source Charge	$Q_{GS}$	V <sub>GS</sub> = -53 V		23		nC	
Gate-Drain Charge	$Q_{GD}$	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 0800 V		77		nC	
Gate Charge - Total	Q <sub>G</sub>			100		nC	
B: Switching <sup>1</sup>							
Internal Gate Resistance – zero bias	$R_{G(INT-ZERO)}$	163 - 0 1, 1 - 110 0		1.7		Ω	
Internal Gate Resistance – ON	R <sub>G(INT-ON)</sub>	$V_{GS} > 2.5 \text{ V}, V_{DS} = 0 \text{ V}, T_j = 175 ^{\circ}\text{C}$		0.13		Ω	
Turn On Delay Time	t <sub>d(on)</sub>		_	12		ns	
Fall Time, V <sub>DS</sub>	t <sub>f</sub>	$I_{D} = 20 \text{ A}$ , Resistive Load		14		ns	Fig. 11, 13
Turn Off Delay Time	t <sub>d(off)</sub>	Refer to Section V for additional		24		ns	
Rise Time, V <sub>DS</sub>	tr	driving information.		12		ns	Fig. 12, 14
Turn On Delay Time	t <sub>d(on)</sub>		_	15		ns	
Fall Time, V <sub>DS</sub>	t <sub>f</sub>	T <sub>i</sub> = 175 °C, V <sub>DS</sub> = 800 V,		13		ns	Fig. 11
Turn Off Delay Time	t <sub>d(off)</sub>	$I_D = 20$ A, Resistive Load		30		ns	
Rise Time, V <sub>DS</sub>	tr			10		ns	Fig. 12
Turn-On Energy Per Pulse	Eon	T <sub>i</sub> = 25 °C, V <sub>DS</sub> = 800 V,		316		μJ	Fig. 11, 13
Turn-Off Energy Per Pulse	E <sub>off</sub>	I <sub>D</sub> = 20 A, Inductive Load		40		μJ	Fig. 12, 14
Total Switching Energy	E <sub>tot</sub>	Refer to Section V.		356		μJ	
Turn-On Energy Per Pulse	Eon	T 475 20 V 020 V		298		μJ	Fig. 11
Turn-Off Energy Per Pulse	E <sub>off</sub>	$-T_j = 175 ^{\circ}C, V_{DS} = 800 V,$ $-I_D = 20 A, Inductive Load$		28		μJ	Fig. 12
Total Switching Energy $E_{tot}$		$m_{\rm D} = 20$ Å, muuulive Luau		326		μJ	

 $^{1}$  – All times are relative to the Drain-Source Voltage  $V_{\text{DS}}$ 

## 

## GA20JT12-247

Section IV: Figures

#### **A: Static Characteristic Figures**

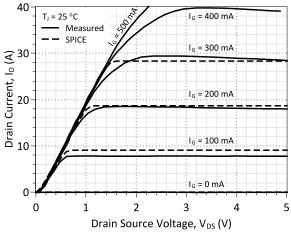


Figure 1: Typical Output Characteristics at 25 °C

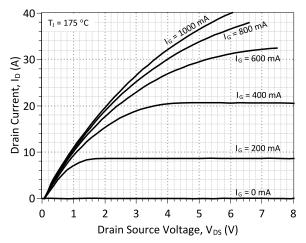


Figure 3: Typical Output Characteristics at 175 °C

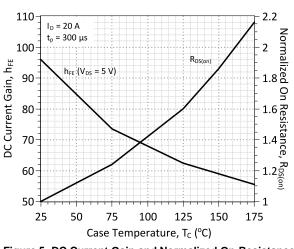


Figure 5: DC Current Gain and Normalized On-Resistance vs. Temperature

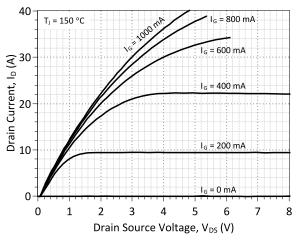


Figure 2: Typical Output Characteristics at 150 °C

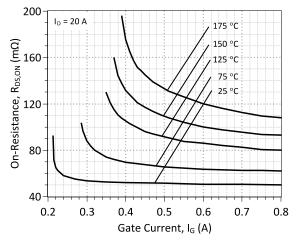


Figure 4: On-Resistance vs. Gate Current

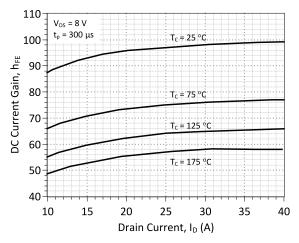
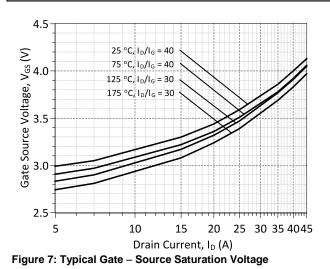


Figure 6: DC Current Gain vs. Drain Current

## GA20JT12-247



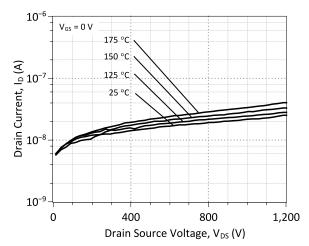


Figure 8: Typical Blocking Characteristics

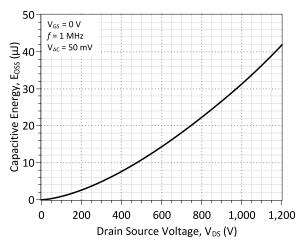


Figure 10: Energy Stored in Output Capacitance

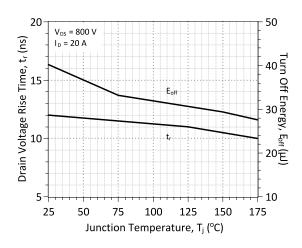


Figure 12: Typical Switching Times and Turn Off Energy Losses vs. Temperature

**B:** Dynamic Characteristic Figures

Dυ

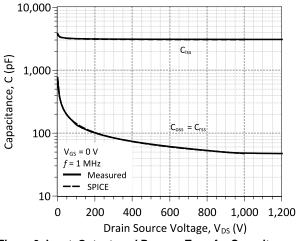


Figure 9: Input, Output, and Reverse Transfer Capacitance

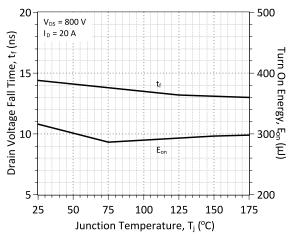
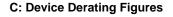


Figure 11: Typical Switching Times and Turn On Energy Losses vs. Temperature

## <u>Jene</u> MICONDUC

#### 20 800 V<sub>DS</sub> = 800 V T = 25 °C Drain Voltage Fall Time, t<sub>f</sub> (ns) 700 600 3 tf Cn 500 Ener 400 % 10 300<sub>Ê</sub> Eon 200 100 5 20 16 18 22 24 Drain Current, I<sub>D</sub> (A)

Figure 13: Typical Switching Times and Turn On Energy Losses vs. Drain Current



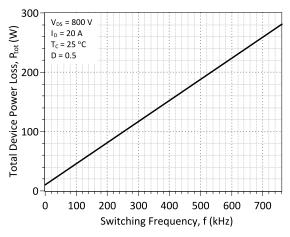


Figure 15: Typical Hard Switched Device Power Loss vs. Switching Frequency<sup>2</sup>

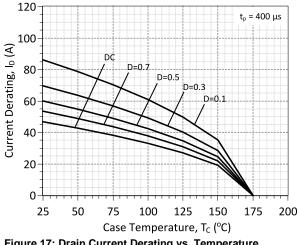


Figure 17: Drain Current Derating vs. Temperature



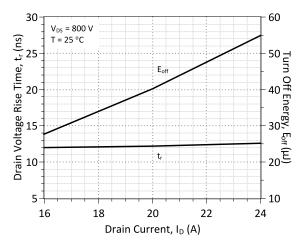
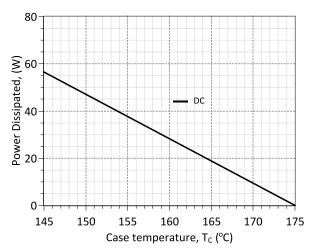
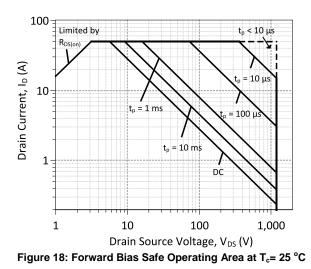


Figure 14: Typical Switching Times and Turn Off Energy Losses vs. Drain Current







<sup>2</sup> - Representative values based on device conduction and switching loss. Actual losses will depend on gate drive conditions, device load, and circuit topology.

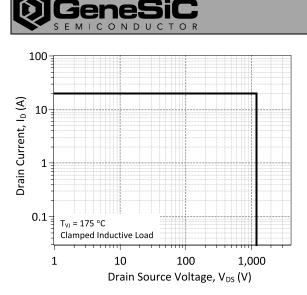


Figure 19: Turn-Off Safe Operating Area

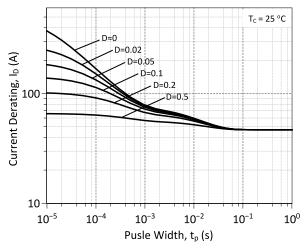
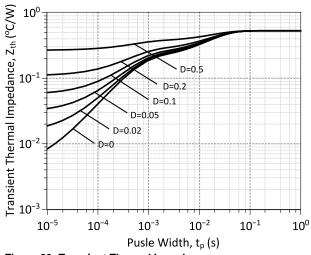


Figure 21: Drain Current Derating vs. Pulse Width



GA20JT12-247

Figure 20: Transient Thermal Impedance



#### Section V: Driving the GA20JT12-247

Drive Topology	Gate Drive Power Consumption	Switching Frequency Application Emphasis		Availability
TTL Logic	High	Low	Wide Temperature Range	Coming Soon
Constant Current	Medium Medium Wide Temper		Wide Temperature Range	Coming Soon
High Speed – Boost Capacitor	Medium	High	Fast Switching	Production
High Speed – Boost Inductor	Low	High	Ultra Fast Switching	Coming Soon
Proportional	Lowest	High	Wide Drain Current Range	Coming Soon
Pulsed Power	Medium	N/A	Pulse Power	Coming Soon

#### A: Static TTL Logic Driving

The GA20JT12-247 may be driven using direct (5 V) TTL logic after current amplification. The (amplified) current level of the supply must meet or exceed the steady state gate current ( $I_{G,steady}$ ) required to operate the GA20JT12-247. The power level of the supply can be estimated from the target duty cycle of the particular application.  $I_{G,steady}$  is dependent on the anticipated drain current ID through the SJT and the DC current gain  $h_{FE,}$  it may be calculated from the following equation. An accurate value of the  $h_{FE}$  may be read from Figure 6.

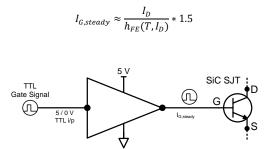


Figure 22: TTL Gate Drive Schematic

#### **B: High Speed Driving**

The SJT is a current controlled transistor which requires a positive gate current for turn-on as well as to remain in on-state. An ideal gate current waveform for ultra-fast switching of the SJT, while maintaining low gate drive losses, is shown in Figure 23 which features a positive current peak during turn-on, a negative current peak during turn-off, and continuous gate current to remain on.

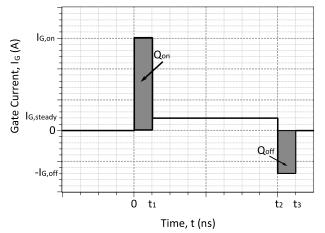


Figure 23: An idealized gate current waveform for fast switching of an SJT.

An SJT is rapidly switched from its blocking state to on-state, when the necessary gate charge,  $Q_G$ , for turn-on is supplied by a burst of high gate current,  $I_{G,on}$ , until the gate-source capacitance,  $C_{GS}$ , and gate-drain capacitance,  $C_{GD}$ , are fully charged.

$$Q_{on} = I_{G,on} * t_1$$
$$Q_{on} \ge Q_{gs} + Q_{gd}$$



Ideally,  $I_{G,pon}$  should terminate when the drain voltage falls to its on-state value in order to avoid unnecessary drive losses during the steady on-state. In practice, the rise time of the  $I_{G,on}$  pulse is affected by the parasitic inductances,  $L_{par}$  in the device package and drive circuit. A voltage developed across the parasitic inductance in the source path,  $L_s$ , can de-bias the gate-source junction, when high drain currents begin to flow through the device. The voltage applied to the gate pin should be maintained high enough, above the  $V_{GS,sat}$  (see Figure 7) level to counter these effects.

A high negative peak current,  $-I_{G,off}$  is recommended at the start of the turn-off transition, in order to rapidly sweep out the injected carriers from the gate, and achieve rapid turn-off. While satisfactory turn off can be achieved with  $V_{GS} = 0$  V, a negative gate voltage  $V_{GS}$  may be used in order to speed up the turn-off transition.

Two high-speed drive topologies for the SiC SJTs are presented below.

#### B:1: High Speed, Low Loss Drive with Boost Capacitor, GA03IDDJT30-FR4

The GA20JT12-247 may be driven using a High Speed, Low Loss Drive with Boost Capacitor topology in which multiple voltage levels, a gate resistor, and a gate capacitor are used to provide fast switching current peaks at turn-on and turn-off and a continuous gate current while in on-state. A 3 kV isolated evaluation gate drive board (GA03IDDJT30-FR4) utilizing this topology is commercially available for high and low-side driving, its datasheet provides additional details about this drive topology.

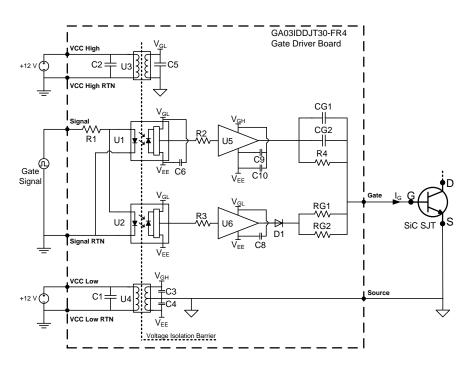


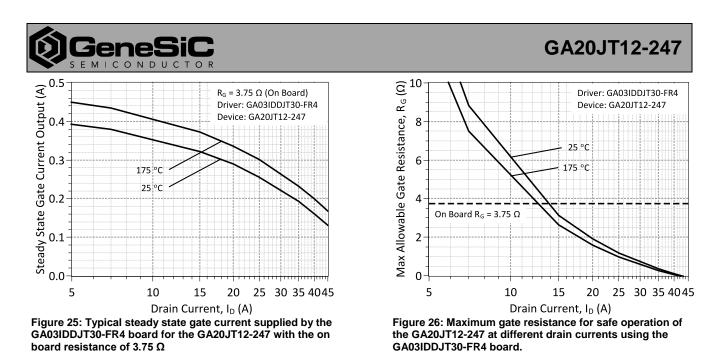
Figure 24: Topology of the GA03IDDJT30-FR4 Two Voltage Source gate driver.

The GA03IDDJT30-FR4 evaluation board comes equipped with two on board gate drive resistors (RG1, RG2) pre-installed for an effective gate resistance<sup>3</sup> of  $R_G$  = 3.75  $\Omega$ . It may be necessary for the user to reduce RG1 and RG2 under high drain current conditions for safe operation of the GA20JT12-247. The steady state current supplied to the gate pin of the GA20JT12-247 with on-board  $R_G$  = 3.75  $\Omega$ , is shown in Figure 25. The maximum allowable safe value of  $R_G$  for the user's required drain current can be read from Figure 26.

#### For the GA20JT12-247, R<sub>g</sub> must be reduced for $I_D \ge \sim 13$ A for safe operation with the GA03IDDJT30-FR4.

For operation at  $I_D \ge \sim 13$  A,  $R_G$  may be calculated from the following equation, which contains the DC current gain  $h_{FE}$  (Figure 6) and the gate-source saturation voltage  $V_{GS,sat}$  (Figure 7).

$$R_{G,max} = \frac{\left(4.7V - V_{GS,sat}\right) * h_{FE}(T, I_D)}{I_D * 1.5} - 0.6\Omega$$



#### B:2: High Speed, Low Loss Drive with Boost Inductor

A High Speed, Low-Loss Driver with Boost Inductor is also capable of driving the GA20JT12-247 at high-speed. It utilizes a gate drive inductor instead of a capacitor to provide the high-current gate current pulses  $I_{G,on}$  and  $I_{G,off}$ . During operation, inductor L is charged to a specified  $I_{G,on}$  current value then made to discharge  $I_L$  into the SJT gate pin using logic control of S<sub>1</sub>, S<sub>2</sub>, S<sub>3</sub>, and S<sub>4</sub>, as shown in Figure 27. After turn on, while the device remains on the necessary steady state gate current  $I_{G,steady}$  is supplied from source V<sub>CC</sub> through R<sub>G</sub>. Please refer to the article "A current-source concept for fast and efficient driving of silicon carbide transistors" by Dr. Jacek Rąbkowski for additional information on this driving topology.<sup>4</sup>

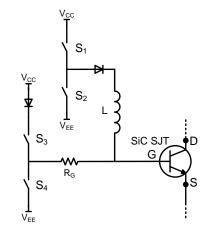


Figure 27: Simplified Inductive Pulsed Drive Topology

<sup>4</sup> – Archives of Electrical Engineering. Volume 62, Issue 2, Pages 333–343, ISSN (Print) 0004-0746, DOI: 10.2478/aee-2013-0026, June 2013

 $<sup>^{3}</sup>$  - R<sub>G</sub> = (1/RG1 + 1/RG2)<sup>-1</sup>. Driver is pre-installed with RG1 = RG2 = 7.5  $\Omega$ 



#### **C: Proportional Gate Current Driving**

For applications in which the GA20JT12-247 will operate over a wide range of drain current conditions, it may be beneficial to drive the device using a proportional gate drive topology to optimize gate drive power consumption. A proportional gate drive relies on instantaneous drain current  $I_D$  feedback to vary the steady state gate current  $I_{G, steady}$  supplied to the GA20JT12-247

#### C:1: Voltage Controlled Proportional Driver

The voltage controlled proportional driver relies on a gate drive IC to detect the GA20JT12-247 drain-source voltage  $V_{DS}$  during on-state to sense I<sub>D</sub>. The gate drive IC will then increase or decrease I<sub>G,steady</sub> in response to I<sub>D</sub>. This allows I<sub>G,steady</sub>, and thus the gate drive power consumption, to be reduced while I<sub>D</sub> is relatively low or for I<sub>G,steady</sub> to increase when is I<sub>D</sub> higher. A high voltage diode connected between the drain and sense protects the IC from high-voltage when the driver and GA20JT12-247 are in off-state. A simplified version of this topology is shown in Figure 29, additional information will be available in the future at http://www.genesicsemi.com/commercial-sic/sic-junction-transistors/

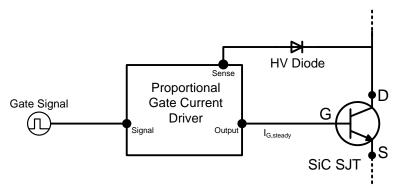


Figure 28: Simplified Voltage Controlled Proportional Driver

#### **C:2: Current Controlled Proportional Driver**

The current controlled proportional driver relies on a low-loss transformer in the drain or source path to provide feedback  $I_D$  of the GA20JT12-247 during on-state to supply  $I_{G,steady}$  into the device gate.  $I_{G,steady}$  will then increase or decrease in response to  $I_D$  at a fixed forced current gain which is set be the turns ratio of the transformer,  $h_{force} = I_D / I_G = N_2 / N_1$ . GA20JT12-247 is initially tuned-on using a gate current pulse supplied into an RC drive circuit to allow  $I_D$  current to begin flowing. This topology allows  $I_{G,steady}$ , and thus the gate drive power consumption, to be reduced while  $I_D$  is relatively low or for  $I_{G,steady}$  to increase when is  $I_D$  higher. A simplified version of this topology is shown in Figure 29, additional information will be available in the future at http://www.genesicsemi.com/commercial-sic/sic-junction-transistors/.

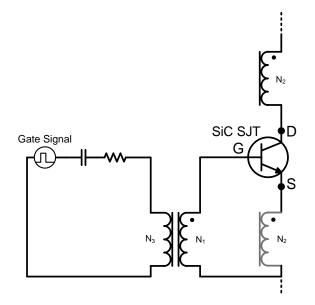
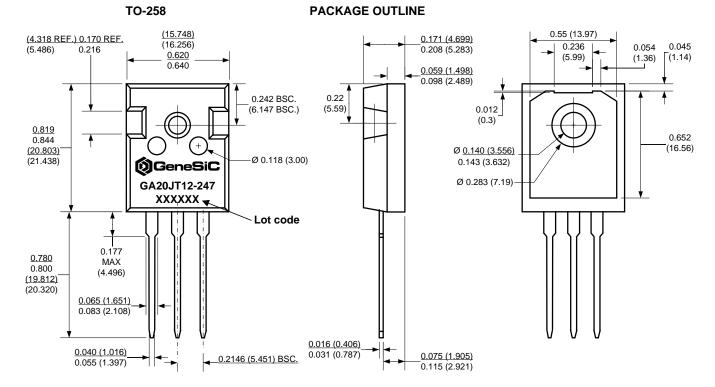


Figure 29: Simplified Current Controlled Proportional Driver



## Section VI: Package Dimensions

GeneSiC



#### NOTE

1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.

2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS

Revision History						
Date Revision Comments Supe						
2015/01/29	2	Updated Electrical Characteristics				
2014/11/13	1	Updated Electrical Characteristics				
2014/08/25	0	Initial release				

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## GeneSiC

#### Section VII: SPICE Model Parameters

This is a secure document. Please copy this code from the SPICE model PDF file on our website (http://www.genesicsemi.com/images/products\_sic/sjt/GA20JT12-247\_SPICE.pdf) into LTSPICE (version 4) software for simulation of the GA20JT12-247.

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     $Revision:
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* OF ANY KIND EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED
* TO ANY IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A
* PARTICULAR PURPOSE."
* Models accurate up to 2 times rated drain current.
.model GA20JT12 NPN
+ IS
           9.833E-48
+ ISE
           1.073E-26
+ EG
           3.23
+ BF
           100
+ BR
           0.55
           5000
+ IKF
+ NF
           1
+ NE
           2
+ RB
           3.09
+ IRB
           0.006
+ RBM
           0.101
+ RE
           0.005
+ RC
           0.040
+ CJC
           752.4E-12
+ VJC
           3.17
+ MJC
           0.480
           3.014E-09
+ CJE
           3.568
+ VJE
+ MJE
           0.538
+ XTI
           3
           -1.5
+ XTB
           8.500E-3
+ TRC1
+ VCEO
           1200
+ ICRATING 20
+ MFG
       GeneSiC Semiconductor
* End of GA20JT12 SPICE Model
```